

ZXMN3F30FH 30V SOT23 N-channel enhancement mode MOSFET

Summary

V _{(BR)DSS}	R _{DS(on)} (Ω)	I _D (A)
30	0.047 @ V _{GS} = 10V	4.6
	0.065 @ V _{GS} = 4.5V	4.0

Description

This new generation Trench MOSFET from Zetex features low on-resistance achievable with 4.5V gate drive.

Features

- · Low on-resistance
- 4.5V gate drive capability
- SOT23

Applications

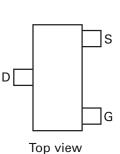
- DC-DC Converters
- Power management functions
- Motor Control

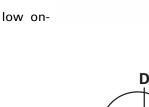
Ordering information

DEVICE	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXMN3F30FHTA	7	8	3000

Device marking

KNA







Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	V _{DSS}	30	V
Gate source voltage	V _{GS}	±20	V
Continous Drain Current @ V _{GS} =4.5; T _A =25°C ^(b)	۱ _D	4.6	А
@ V _{GS} =4.5; T _A =70°C ^(b)		3.7	A
@ V _{GS} =4.5; T _A =25°C ^(a)		3.8	А
Pulsed drain current ^(c)	I _{DM}	21	А
Continuous source current (body diode) ^(b)	۱ _S	2.2	А
Pulsed source current (body diode) ^(c)	I _{SM}	21	А
Power dissipation at $T_A = 25^{\circ}C^{(a)}$	PD	0.95	W
Linear derating factor		7.6	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)}$	PD	1.4	W
Linear derating factor		11.2	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit	
Junction to ambient ^(a)	R _{⊖JA}	131	°C/W	
Junction to ambient ^(b)	R _{OJA}	89	°C/W	
Junction to lead ^(d)	R _{ƏJL}	68	°C/W	

NOTES:

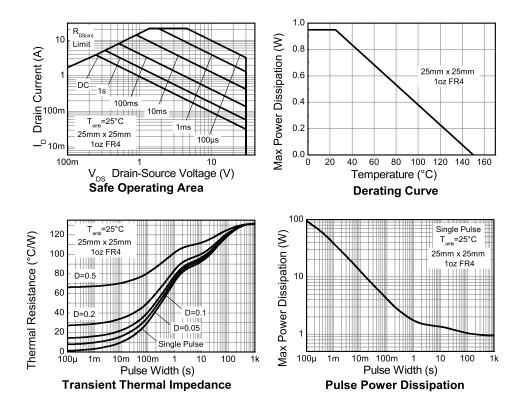
(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) For a device surface mounted on FR4 PCB measured at t \leq 5 sec.

(c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width 300µs - pulse width limited by maximum junction temperature.

(d) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics



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Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Static	1			1			
Drain-Source breakdown Voltage	V _{(BR)DSS}	30			V	I _D = 250μA, V _{GS} =0V	
Zero gate voltage drain current	I _{DSS}			0.5	μA	V _{DS} = 30V, V _{GS} =0V	
Gate-body leakage	I _{GSS}			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$	
Gate-Source threshold voltage	V _{GS(th)}	1.0		3.0	V	I _D = 250μA, V _{DS} =V _{GS}	
Static Drain-Source on-state resistance ^(*)	R _{DS(on)}			0.047 0.065	Ω Ω	V _{GS} = 10V, I _D = 3.2A V _{GS} = 4.5V, I _D = 2.8A	
Forward transconductance ^{(*)(†)}	g _{fs}		5.2		S	V _{DS} = 15V, I _D = 2.5A	
Dynamic ^(†)							
Input capacitance	C _{iss}		318		pF		
Output capacitance	C _{oss}		75		pF	V _{DS} = 15V, V _{GS} =0V f=1MHz	
Reverse transfer capacitance	C _{rss}		45		pF		
Switching ^{(†) (‡)}							
Turn-on-delay time	t _{d(on)}		1.6		ns		
Rise time	t _r		2.6		ns	V _{DD} = 15V, V _{GS} = 10V I _D = 1A	
Turn-off delay time	t _{d(off)}		17		ns	$R_{G} \approx 6.0\Omega$	
Fall time	t _f		9.3		ns		
Total gatecharge	Q _g		7.7		nC	V _{DS} = 15V, V _{GS} = 10V	
Gate-Source charge	Q _{gs}		1		nC	I _D = 2.5A	
Gate-Drain charge	0 _{gd}		1.8		nC	1	
Source-drain diode				1			
Diode forward voltage ^(*)	V _{SD}		0.73	1.2	V	I _S = 1.25A, V _{GS} =0V	
Reverse recovery time ^(†)	t _{rr}		12		ns	T _j =25°C, I _F =1.6A	
Reverse recovery charge ^(†)	0 _{rr}		4.8		nC	di/dt=100A/μs	

Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

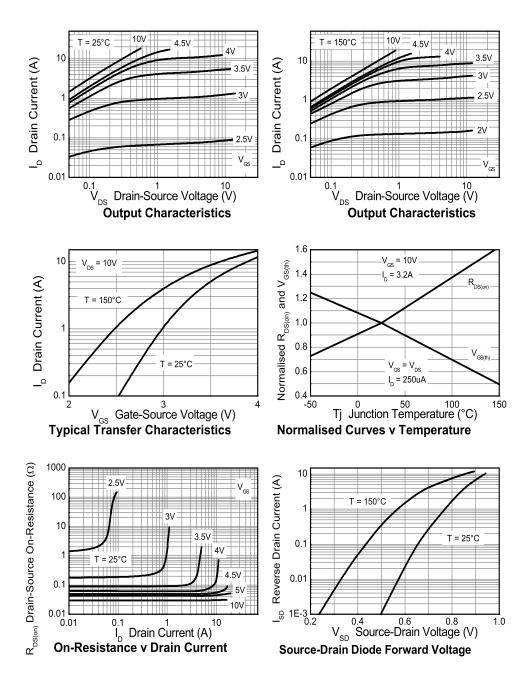
NOTES:

(*) Measured under pulsed conditions. Pulse width \leq 300µs; duty cycle \leq 2%.

(†) For design aid only, not subject to production testing.

(‡) Switching characteristics are independent of operating junction temperature.

Typical characteristics



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Current regulator

50k 1h 7 Same a D.U.T

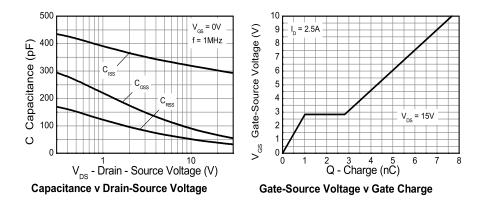
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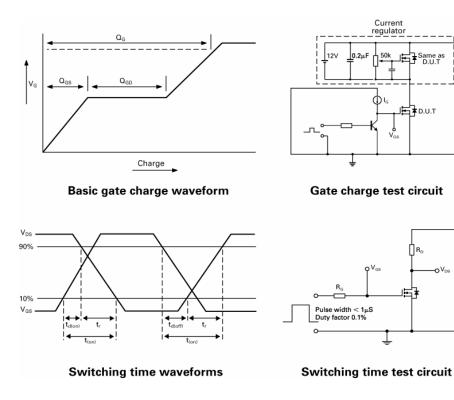
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Typical characteristics

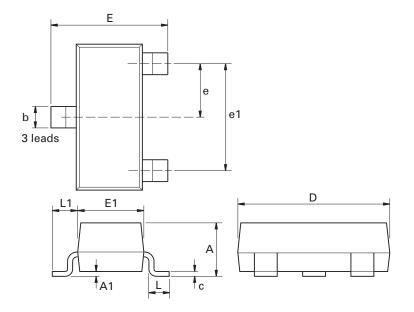


Test circuits



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Package outline - SOT23



Dim.	Millin	neters	Inc	hes	Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
А	-	1.12	-	0.044	e1	1.90	NOM	0.075	NOM
A1	0.01	0.10	0.0004	0.004	E	2.10	2.64	0.083	0.104
b	0.30	0.50	0.012	0.020	E1	1.20	1.40	0.047	0.055
С	0.085	0.20	0.003	0.008	L	0.25	0.60	0.0098	0.0236
D	2.80	3.04	0.110	0.120	L1	0.45	0.62	0.018	0.024
е	0.95	NOM	0.037	NOM	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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